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SEMICONDUCTOR

Si3456DV N-Channel PowerTrench[®] MOSFET

General Description

These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced Power Trench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

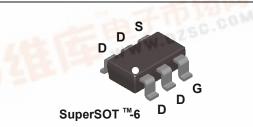
These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

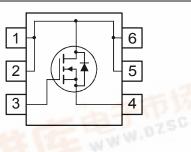


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Features

- 5.1 A, 30 V. $R_{DS(ON)} = 45 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 65 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- High performance trench technology for extremely low R_{DS(ON)}
- Low gate charge
- High power and current handling capability





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		±20	V
D	Drain Current – Continuo	DUS (Note 1a)	5.1	A
	- Pulsed		20	
P _D	Maximum Power Dissipati	ON (Note 1a)	1.6	W
		(Note 1b)	0.8	
J, T _{STG}	Operating and Storage Ju	nction Temperature Range	-55 to +150	°C
	I Characteristics Thermal Resistance, Junc	tion-to-Ambient (Note 1a)	78	°C/W
Therma ୧ _{୶୲ନ} ୧ _{୶୲c}	Thermal Resistance, Junc Thermal Resistance, Junc		78 30	•C/W
R _{eja} Rejc Packag Device I	Thermal Resistance, Junc Thermal Resistance, Junc	tion-to-Case (Note 1) dering Information Reel Size		C/W Quantity 3000 units



Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics				<u> </u>	<u> </u>
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 \mu A$	30			V
ΔBV _{DSS} ΔTJ	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		25		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 30 V$, $V_{GS} = 0 V$ $T_{I}=70^{\circ}C$			1 5	μA
I _{GSS}	Gate–Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1	1.5	2	V
$\Delta V_{GS(th)}$ ΔT_J	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		-4		mV/°
R _{DS(on)}	Static Drain–Source On–Resistance			33 44 49	45 65 71	mΩ
I _{D(on)}	On–State Drain Current	V _{GS} = 10 V, V _{DS} = 5 V	15			Α
g fs	Forward Transconductance	$V_{DS} = 10 V$, $I_D = 5.1 A$		12		S
Dynamic	Characteristics					
Ciss	Input Capacitance	$V_{DS} = 15 V$, $V_{GS} = 0 V$,		463		pF
Coss	Output Capacitance	f = 1.0 MHz		109		pF
Crss	Reverse Transfer Capacitance]		44		pF
R _G	Gate Resistance	V_{GS} = 15 mV, f = 1.0 MHz		1.1		Ω
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time	$V_{DS} = 15 V$, $I_D = 1 A$,		6.3	13	nS
t _r	Turn–On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \ \Omega$		6	12	nS
t _{d(off)}	Turn–Off Delay Time	1		20	36	nS
t _f	Turn–Off Fall Time			2.3	4.6	nS
Q _g	Total Gate Charge	$V_{DS} = 15 V$, $I_D = 5.1 A$,		9	12.6	nC
Q _{gs}	Gate–Source Charge	V _{GS} = 10 V		1.4		nC
Q _{gd}	Gate-Drain Charge	1		1.6		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings				
l _s	Maximum Continuous Drain–Sourc	V			1.3	А
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 1.3 A$ (Note 2)		0.77	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 5.1A		18		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A}/\mu \text{s}$ (Note 2)		17		nC

Notes:

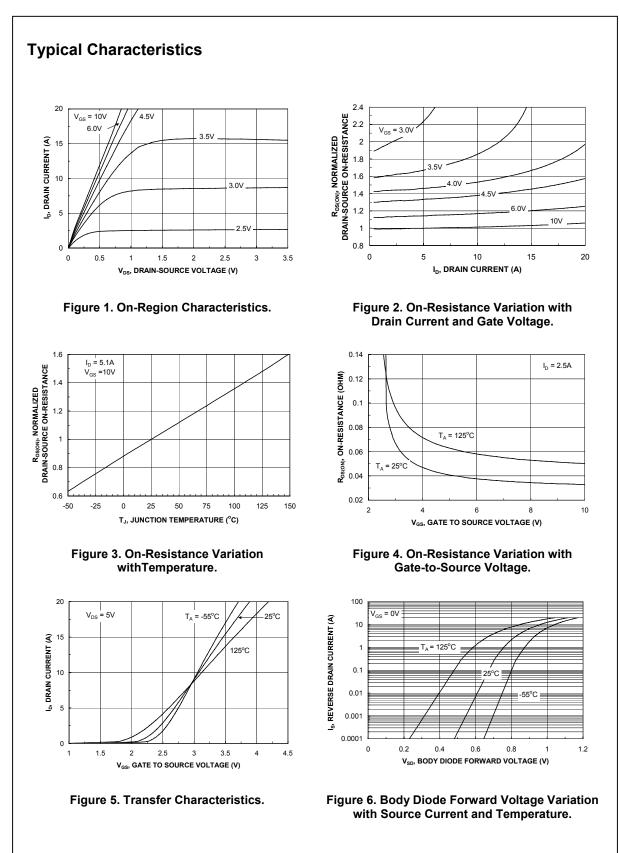
1. R_{0JA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.

a. 78° C/W when mounted on a $1in^2$ pad of 2oz copper on FR-4 board.

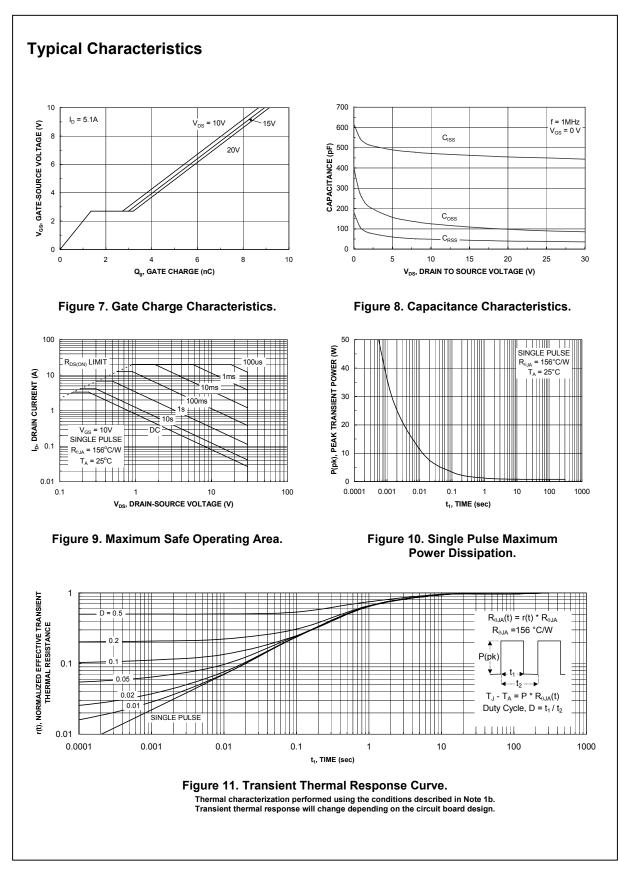
b. 156°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width \leq 300 $\mu\text{s},$ Duty Cycle \leq 2.0%

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